# IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Prior Group Art Unit: 2185

Prior Examiner: Mark A. Connolly

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Applicant(s)	:	Bi-Yun YEH et al.	)	
Serial No.	:	Continuation-in-part of Appl. Serial No. 09/481,714	)	
Filed	:	July 29, 2003	)	INFORMATION
For	:	COMPUTER SYSTEM FOR ACCESSING INITIALIZATION DATA AND METHOD THEREFOR	) ) )	DISCLOSURE
Attorney Ref.	:	SUND 114 CIP	) )_	

Commissioner for Patents Washington, D.C. 20231

Sir:

In accordance with the duty of disclosure, attached are copies of the Forms PTO-1449 and 892 from the parent application, serial number, **09/481,714**, which the Examiner may wish to consult during examination of this Continuation Application thereof.

Respectfully submitted,

July 29, 2003

Date

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# Notice of R ferences Cited Application/Control No. O9/481,714 Examiner Art Unit Page 1 of 1 U.S. PATENT DOCUMENTS Applicant(s)/Patent Under Reexamination YEH ET AL. Page 1 of 1

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,253,276	06-2001	Jeddeloh, Joseph M.	711/5
	В	US-6,022,274	02-2000	Takeda et al.	463/44
	С	US-5,375,161	12-1994	Fuller et al.	455/417
	D	US-4,213,182	07-1980	Eichelberger et al.	700/296
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# **FOREIGN PATENT DOCUMENTS**

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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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### Application/Control No. Applicant(s)/Patent Under Reexamination 09/481,714 YEH ET AL. Notice of Referenc s Cited Examiner Art Unit Page 1 of 1 Mark Connolly 2185 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-5,592,675 01-1997 Itoh et al. 365/222 Α US-5,936,526 08-1999 Klein, Dean A. В 340/571 С US-5,937,434 08-1999 Hasbun et al. 711/156 01-2000 D US-6,014,760 Silva et al. 705/8 Ε US-F US-G US-US-Н US-1 J US-US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) W Х

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